

<b>Notice of References Cited</b>	Application/Control No. 10/734,188		Applicant(s)/Patent Under Reexamination VON GLAN, RUDOLF E.	
	Examiner Susan Y. Chen		Art Unit 2161	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,289,334	09-2001	Reiner et al.	707/3
*	B	US-6,327,591	12-2001	Osborn et al.	707/10
*	C	US-6,012,067	01-2000	Sarkar, Shyam Sundar	707/103R
*	D	US-6,823,377	11-2004	Wu et al.	709/223
*	E	US-2004/0260684	12-2004	Agrawal et al.	707/003
*	F	US-2005/0131893	06-2005	Von Glan, Rudolf E.	707/005
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.